



UT90N03M

Preliminary

POWER MOSFET

90A, 30V N-CHANNEL ENHANCEMENT MODE POWER MOSFET

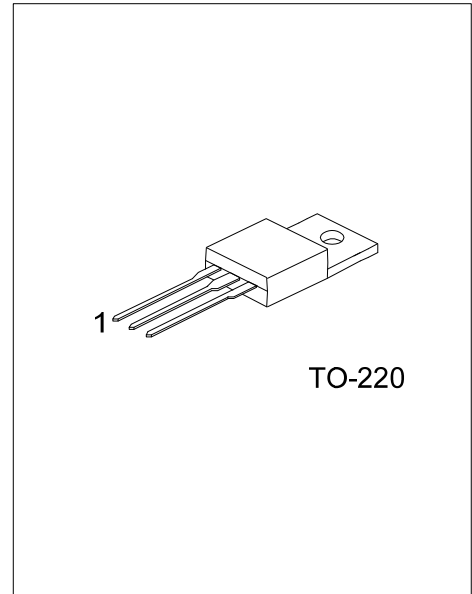
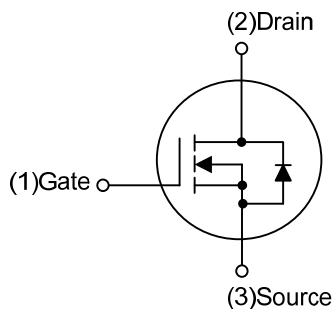
DESCRIPTION

The UTC **UT90N03M** is a N-channel power MOSFET providing very low on-resistance. It has high efficiency and perfect cost-effectiveness. It can be generally applied in the commercial and industrial fields.

FEATURES

- * $R_{DS(ON)} \leq 4.5 \text{ m}\Omega$ @ $V_{GS} = 10\text{V}$, $I_D = 45\text{A}$
 $R_{DS(ON)} \leq 5.5 \text{ m}\Omega$ @ $V_{GS} = 4.5\text{V}$, $I_D = 30\text{A}$
- * Improved dv/dt capability
- * Simple drive requirement

SYMBOL



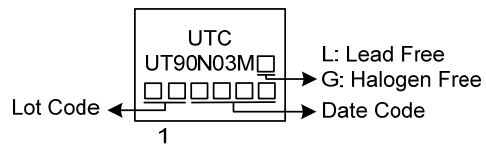
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UT90N03ML-TA3-T	UT90N03MG-TA3-T	TO-220	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

UT90N03MG-TA3-T		(1)Packing Type	(1) T: Tube
		(2)Package Type	(2) TA3: TO-220
		(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ ABSOLUTE MAXIMUM RATING ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	V
Drain Current	DC	I_D	90	A
	Pulsed (Note 2)	I_{DM}	180	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	49	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.44	V/ns
Power Dissipation		P_D	220	W
Junction Temperature		T_J	+150	$^{\circ}\text{C}$
Storage Temperature Range		T_{STG}	-55 ~ +150	$^{\circ}\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

3. $L = 0.1\text{mH}$, $I_{AS} = 31.35\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\ \Omega$, Starting $T_J = 25^{\circ}\text{C}$

4. $I_{SD} \leq 30\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 25^{\circ}\text{C}$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	62.5	$^{\circ}\text{C}/\text{W}$
Junction to Case	θ_{JC}	0.5	$^{\circ}\text{C}/\text{W}$

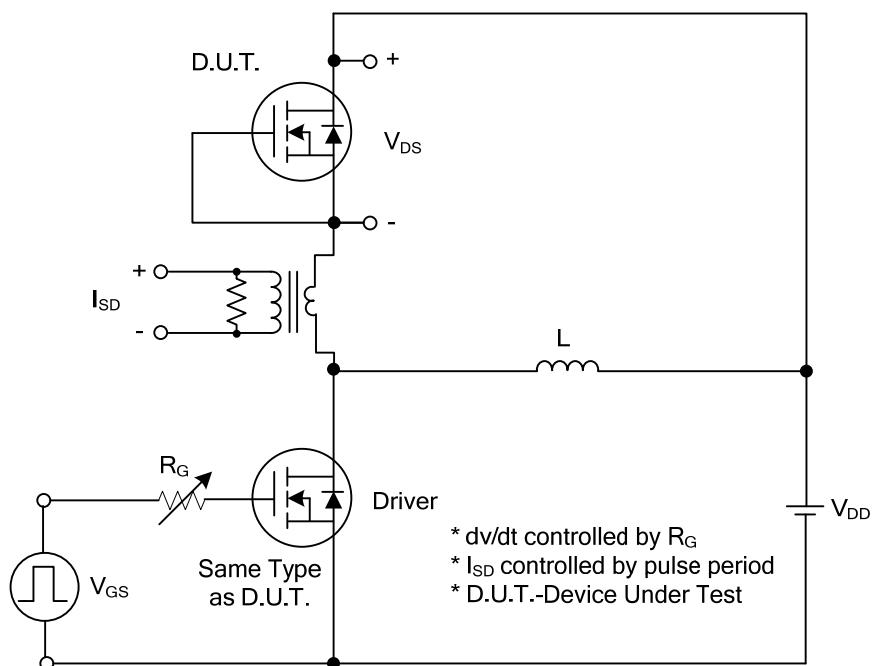
■ ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	30			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	Forward	I _{GSS}	V _{GS} =+20V, V _{DS} =0V			+100	nA
	Reverse		V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} = V _{GS} , I _D =250μA	1.0		3.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =45A			4.5	mΩ
			V _{GS} =4.5V, I _D =30A			5.5	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}	V _{GS} =0V, V _{DS} =15V, f=1.0MHz		3078		pF
Output Capacitance		C _{OSS}			580		pF
Reverse Transfer Capacitance		C _{RSS}			512		pF
SWITCHING PARAMETERS							
Total Gate Charge		Q _G	V _{DS} =24V, V _{GS} =10V, I _D =90A (Note 1, 2)		103		nC
Gate to Source Charge		Q _{GS}			15		nC
Gate to Drain Charge		Q _{GD}			27		nC
Turn-ON Delay Time		t _{D(ON)}	V _{DD} =15V, V _{GS} =10V, I _D =90A, R _G =3.3Ω (Note 1, 2)		8		ns
Rise Time		t _R			18		ns
Turn-OFF Delay Time		t _{D(OFF)}			84		ns
Fall-Time		t _F			58		ns
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Continuous Drain-Source Diode Forward Current		I _S				90	A
Maximum Pulsed Drain-Source Diode Forward Current		I _{SM}				180	A
Diode Forward Voltage		V _{SD}	I _F =90A, V _{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =30A, V _{GS} =0V,		295		nS
Reverse Recovery Charge		Q _{rr}	dI _F /dt =100A/μs		976		nC

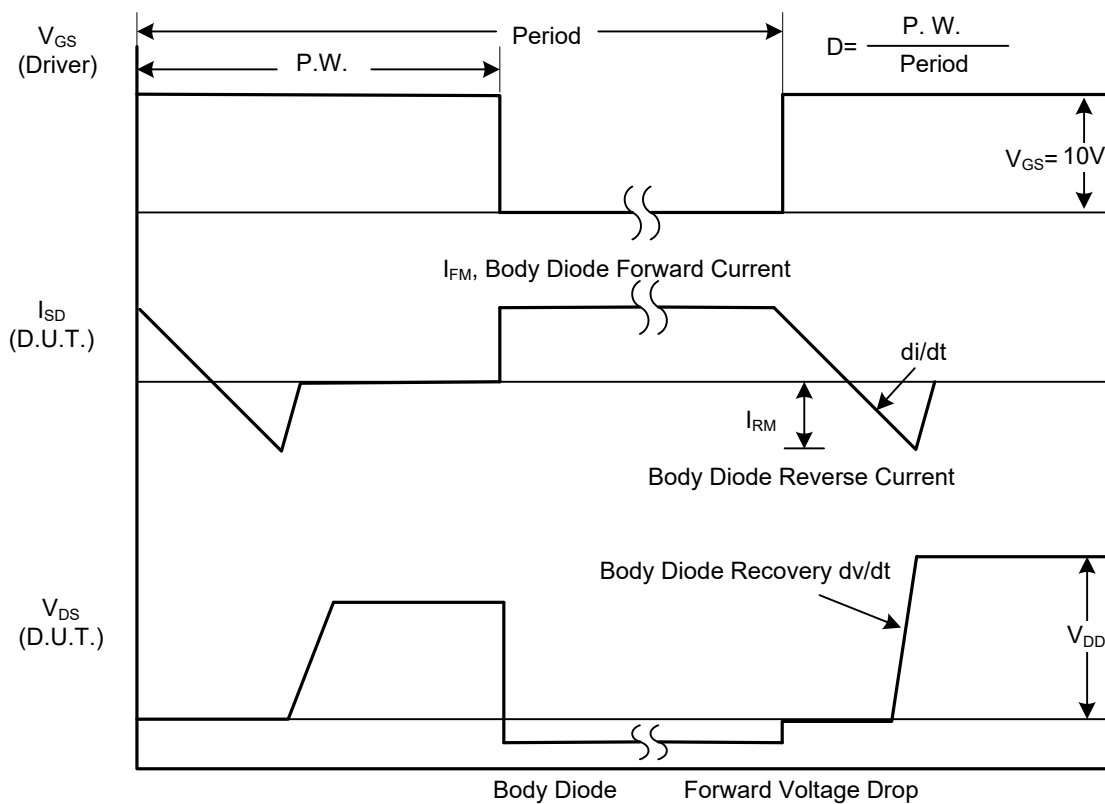
Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

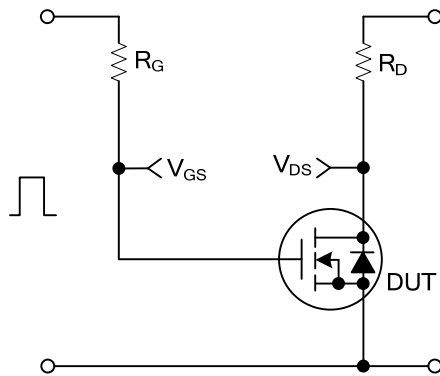


Peak Diode Recovery dv/dt Test Circuit

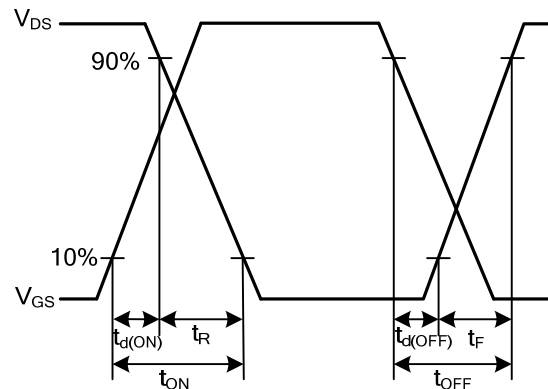


Peak Diode Recovery dv/dt Waveforms

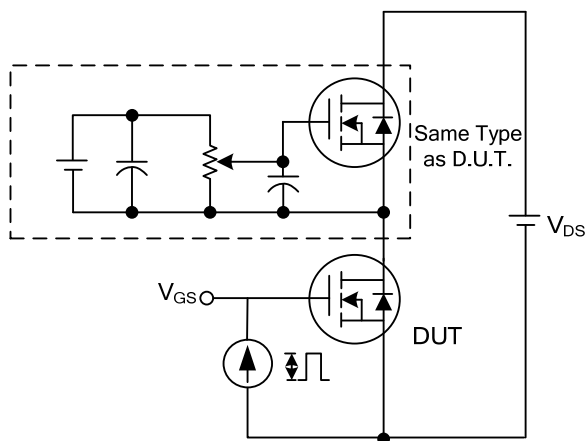
■ TEST CIRCUITS AND WAVEFORMS



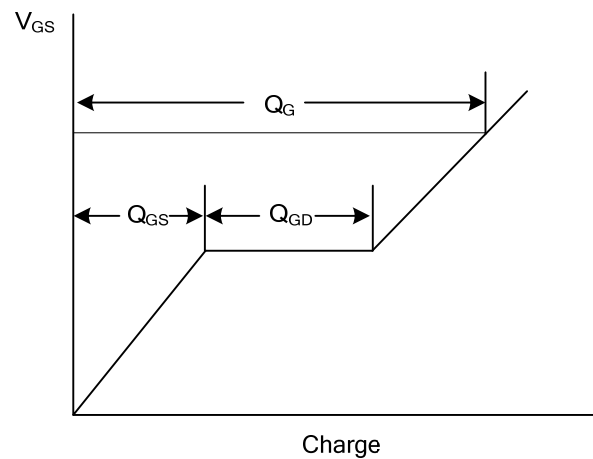
Switching Test Circuit



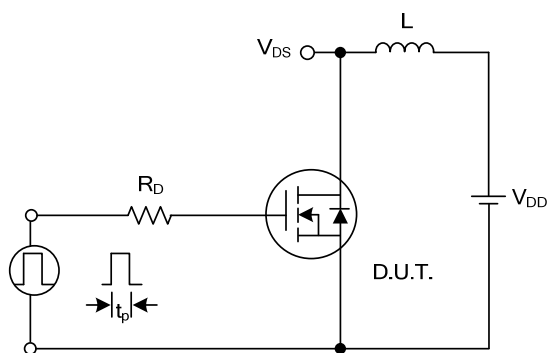
Switching Waveforms



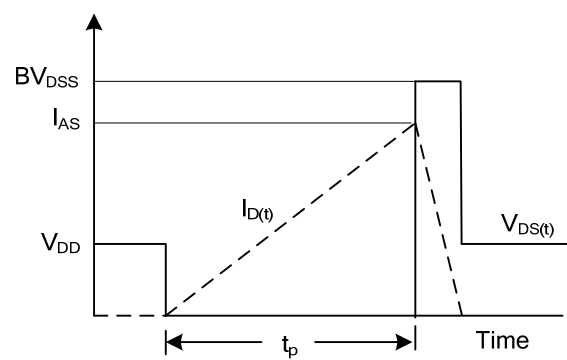
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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